## PRODUCT CHANGE NOTICE

## Data Sheet Specification Change for Intersil Product ISL21440\*

Refer to: PCN11020

Date: February 23, 2011



To: Our Valued Intersil Customer

Subject: Data Sheet Specification Change for Intersil Product ISL21440\*

This notice is to inform you that Intersil has changed the data sheet specification for the listed ISL21440\* products. The change in test conditions for the 3V Output Low Voltage ( $V_{OL}$ ) and 3V Output High Voltage ( $V_{OH}$ ) parameters are necessary to maintain product manufacturability in support of customer delivery requirements. Modifications to the data sheet specification incorporating the changes are complete. The updated data sheet is available on the Intersil web site at <a href="http://www.intersil.com/data/fn/fn6532.pdf">http://www.intersil.com/data/fn/fn6532.pdf</a>.

Products affected: ISL21440IRTZ ISL21440IRTZ-T13 ISL21440IUZ ISL21440IUZ-T13

The data sheet specification changes are as follows:

Analog Specifications $V + = 3.0V$ , $V - = GND = 0V$			
Parameter	Symbol	Test Condition	
		Current	New
Output High Voltage	$V_{\mathrm{OH}}$	$I_O = -7 \text{mA}$	$I_O = -6mA$
Output Low Voltage	$V_{OL}$	$I_O = 3mA$	$I_O = 1.8 \text{mA}$

There will be no change in external marking of the packaged parts. Parts affected by this change are identifiable via Intersil's internal traceability system.

Intersil will take all necessary actions to conform to agreed upon customer requirements and to ensure the continued high quality and reliability of Intersil products being supplied. Customers may expect to receive product electrically screened to the revised data sheet conditions beginning *ninety* days from the date of this notification or earlier with approval.

If you have concerns with this notice, Intersil must hear from you promptly. Please contact the nearest Intersil Sales Office or call the Intersil Corporate line at 1-888-468-3774, in the United States, or 1-321-724-7143 outside of the United States.

Regards,

Jon Brewster

Intersil Corporation PCN11020

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